

Notice of References Cited	Application/Control No. 10/765,125		Applicant(s)/Patent Under Reexamination ONO, HIROSHI	
	Examiner Tan V. Mai		Art Unit 2193	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0050077	03-2003	Takeuchi et al.	455/456
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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